

**Search Notes**

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Examiner

Hai L. Nguyen

Applicant(s)/Patent under  
Reexamination

SCHMIDT, JUERGEN

Art Unit

2816

**SEARCHED**

Class	Subclass	Date	Examiner
327	2, 3, 7, 12, 39, 40	1/7/2008	HLN
327	42, 43	1/8/2008	HLN
327	47 - 49	1/8/2008	HLN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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